

Notice of References Cited

Application/Control No.

10/017,585

Applicant(s)/Patent Under

Reexamination

CHOI ET AL.

Examiner

David L Lewis

Art Unit

2673

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|------------------|----------------|
| | A | US-2002/0008683 A1 | 01-2002 | Makino et al. | 345/88 |
| | B | US-2003/0058210 A1 | 03-2003 | YAMAZAKI et al. | 345/89 |
| | C | US-2002/0000960 A1 | 01-2002 | YOSHIHARA et al. | 345/87 |
| | D | US-6,570,554 B1 | 05-2003 | Makino et al. | 345/102 |
| | E | US-6,392,620 B1 | 05-2002 | Mizutani et al. | 345/88 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.